

# MOSFET – Power, Single N-Channel

40 V, 237 A, 1.2 m $\Omega$ 

#### NTMJS1D2N04CL

#### **Features**

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- LFPAK8 Package, Industry Standard
- These Devices are Pb-Free and are RoHS Compliant

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Symbol	Parameter			Value	Unit	
V <sub>DSS</sub>	Drain-to-Source Voltage			40	٧	
V <sub>GS</sub>	Gate-to-Source Voltage			±20	V	
I <sub>D</sub>	Continuous Drain $T_C = 25^{\circ}C$		T <sub>C</sub> = 25°C	237	Α	
	Current R <sub>0JC</sub> (Notes 1, 3)	Steady	T <sub>C</sub> = 100°C	168		
P <sub>D</sub>	Power Dissipation	State	T <sub>C</sub> = 25°C	128	W	
	R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100°C	64		
I <sub>D</sub>	Continuous Drain		T <sub>A</sub> = 25°C	41	Α	
	Current R <sub>0JA</sub> (Notes 1, 2, 3)	Steady	T <sub>A</sub> = 100°C	29		
P <sub>D</sub>	Power Dissipation	State	T <sub>A</sub> = 25°C	3.8	W	
	R <sub>θJA</sub> (Notes 1, 2)		T <sub>A</sub> = 100°C	1.9		
I <sub>DM</sub>	Pulsed Drain Current	T <sub>A</sub> = 25	°C, t <sub>p</sub> = 10 μs	1480	Α	
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction and Storage Temperature Range			–55 to + 175	°C	
I <sub>S</sub>	Source Current (Body Diode)			107	Α	
E <sub>AS</sub>	Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 19 A)			453	mJ	
TL	Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

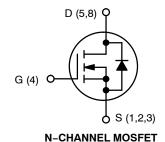
Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Junction-to-Case - Steady State	1.2	°C/W
$R_{\theta JA}$	Junction-to-Ambient - Steady State (Note 2)	36	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

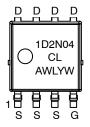
V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX		
40.1/	1.2 m $\Omega$ @ 10 V	007.4		
40 V	1.8 mΩ @ 4.5 V	237 A		



LFPAK8 CASE 760AA



#### **MARKING DIAGRAM**



1D2N04CL = Specific Device Code

A = Assembly Location

WL = Wafer Lot
 Y = Year
 W = Work Week

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information on page 5 of this data sheet.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Symbol	Parameter	Test Condi	Test Condition		Тур	Max	Unit
OFF CHAR	ACTERISTICS	•					
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		40			V
V <sub>(BR)DSS</sub> /	Drain-to-Source Breakdown Voltage Temperature Coefficient				20		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{GS} = 0 V$	$V_{GS} = 0 \text{ V}, \qquad T_{J} = 25^{\circ}\text{C}$			10	
		V <sub>DS</sub> = 40 V	T <sub>J</sub> = 125°C			250	μΑ
I <sub>GSS</sub>	Gate-to-Source Leakage Current	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	s = 20 V			100	nA
ON CHARA	CTERISTICS (Note 6)						
V <sub>GS(TH)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D =$	= 170 μΑ	1.2		2.0	V
V <sub>GS(TH)</sub> /T <sub>J</sub>	Threshold Temperature Coefficient				-5.9		mV/°C
R <sub>DS(on)</sub>	Drain-to-Source On Resistance	V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 50 A		1.5	1.8	mΩ
R <sub>DS(on)</sub>	Drain-to-Source On Resistance	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 50 A		1	1.2	mΩ
9FS	Forward Transconductance	V <sub>DS</sub> = 10 V, I <sub>D</sub>	= 50 A		190		S
CHARGES,	CAPACITANCES & GATE RESISTANCE						-
C <sub>ISS</sub>	Input Capacitance				5600		pF
C <sub>OSS</sub>	Output Capacitance	V <sub>GS</sub> = 0 V, f = 1 MH:		2600			
C <sub>RSS</sub>	Reverse Transfer Capacitance	7			70		
Q <sub>G(TOT)</sub>	Total Gate Charge	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 2	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 20 V; I <sub>D</sub> = 50 A		44		nC
Q <sub>G(TOT)</sub>	Total Gate Charge	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 2	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 20 V; I <sub>D</sub> = 50 A		93		
Q <sub>G(TH)</sub>	Threshold Gate Charge						
$Q_{GS}$	Gate-to-Source Charge		<b>†</b>		17.2		nC
$Q_{GD}$	Gate-to-Drain Charge	$V_{GS} = 10 \text{ V}, V_{DS} = 2$	0 V; I <sub>D</sub> = 50 A		13.6		1
$V_{GP}$	Plateau Voltage	7			3.1		V
SWITCHING	CHARACTERISTICS (Note 7)						-
t <sub>d(ON)</sub>	Turn-On Delay Time				24		
t <sub>r</sub>	Rise Time	V <sub>GS</sub> = 10 V. V <sub>DS</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 20 V, $I_{D}$ = 50 A, $R_{G}$ = 2.5 $\Omega$		72		ns
t <sub>d(OFF)</sub>	Turn-Off Delay Time	I <sub>D</sub> = 50 A, R <sub>G</sub>			122		
t <sub>f</sub>	Fall Time	†			116		
DRAIN-SOL	URCE DIODE CHARACTERISTICS				•		
$V_{SD}$	Forward Diode Voltage	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.76	1.2	
		I <sub>S</sub> = 50 A	T <sub>J</sub> = 125°C		0.66		V
t <sub>RR</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0 V, dIS/dt = 100 A/μs, I <sub>S</sub> = 50 A			59		
ta	Charge Time				29		ns
t <sub>b</sub>	Discharge Time				30		
Q <sub>RR</sub>	Reverse Recovery Charge				43		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

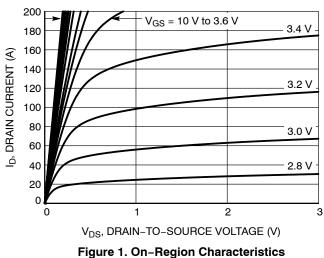
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

<sup>6.</sup> Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

<sup>7.</sup> Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**



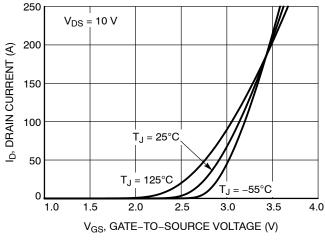


Figure 2. Transfer Characteristics

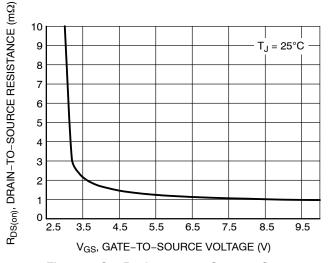


Figure 3. On-Resistance vs. Gate-to-Source Voltage

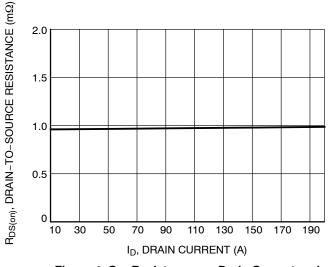


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

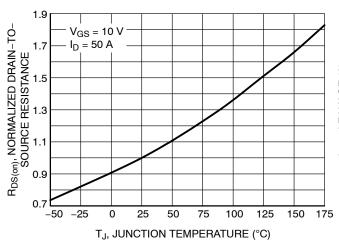


Figure 5. On-Resistance Variation with **Temperature** 

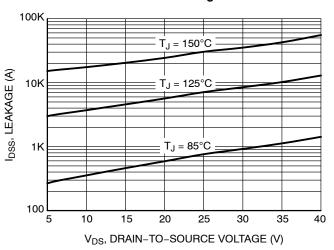


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### TYPICAL CHARACTERISTICS (coninued)

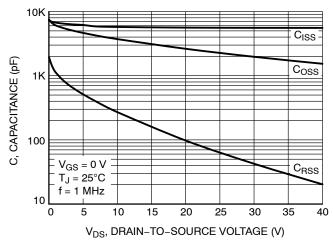


Figure 7. Capacitance Variation

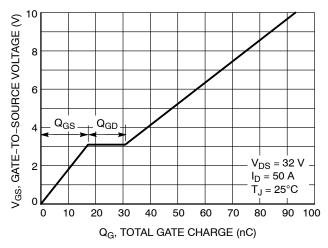


Figure 8. Gate-to-Source Voltage vs. Total Charge

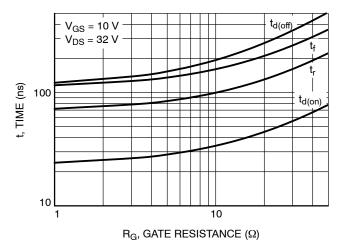


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

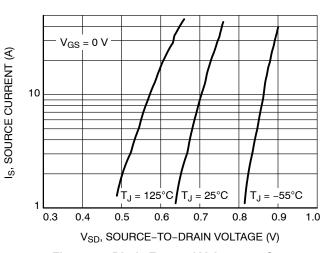


Figure 10. Diode Forward Voltage vs. Current

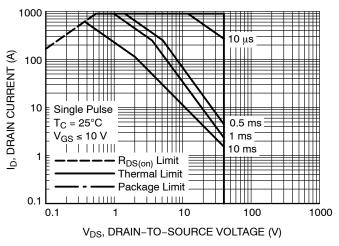


Figure 11. Maximum Rated Forward Biased Safe Operating Area

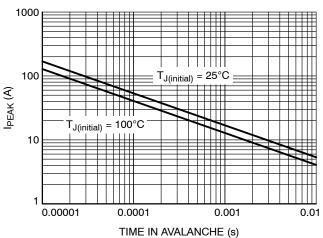


Figure 12. I<sub>PEAK</sub> vs. Time in Avalanche

#### TYPICAL CHARACTERISTICS (coninued)

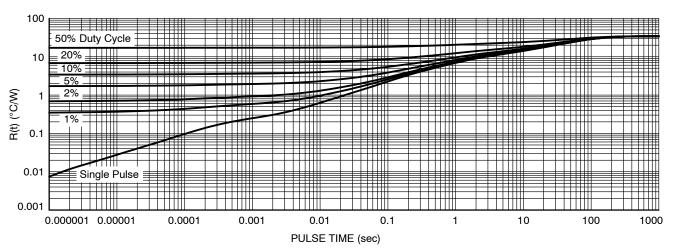


Figure 13. Thermal Characteristics

#### **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NTMJS1D2N04CLTWG	1D2N04 CL	LFPAK8 (Pb-Free)	3,000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





## **LFPAK8 4.90x4.80x1.12MM**, **1.27P**CASE 760AA ISSUE D

**DATE 22 APR 2024** 





#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2018.
- CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.150mm PER SIDE.
- 4. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 5. OPTIONAL MOLD FEATURE.









RECOMMENDED LAND PAD

\*FOR ADDITIONAL INFORMATION ON OUR

MANUAL, SOLDERRM/D.

PB-FREE STRATEGY AND SOLDERING DETAILS.

PLEASE DOWNLOAD THE ONSEMI SOLDERING AND MOUNTING TECHNIQUES REFERENCE

**MILLIMETERS** MIN NOM DIM 1.10 1.20 1.30 Α A1 0.00 0.08 0.15 A2 1.10 1.15 1.20 АЗ 0.25 BSC b 0.40 0.45 0.50 0.45 0.55 0.65 b4 0.19 0.22 0.25 С c2 0.19 0.22 0.25 4.70 4.80 4.90 D D1 3.80 4.00 4.20 2.98 D2 3.08 3.18 D3 0.30 0.40 0.50 D4 0.55 0.65 0.75 4.80 4.90 5.00 Ε E1 5.05 5.15 5.25 E2 3.91 3.96 4.01 1.27 BSC е 0.635 BSC e/2 Н 6.00 6.15 6.30 L 0.50 0.70 0.90 0.25 0.35 L1 0.15 L2 1.10 REF 4° θ

### GENERIC MARKING DIAGRAM\*



XXXXXX = Specific Device Code

= Work Week

A = Assembly Location

WL = Wafer Lot Y = Year

W

\*This information is generic. Please refer to device data sheet for actual part marking. Some products may not follow the Generic Marking.

DOCUMENT NUMBER:

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DESCRIPTION:

LFPAK8 4.90x4.80x1.12MM, 1.27P

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